

<b>Search Notes</b> 				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/539,109	YOSHINO ET AL.	
				Examiner	Art Unit	
				Quang T. Van	3742	
<b>SEARCHED</b>				<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>		
Class	Subclass	Date	Examiner		DATE	EXMR
219	756,750	7/19/06	QV	East search	7/19/06	QV
	710,748			Inventor check	7/19/06	QV
	749,754					
	746,751					
	681					
<i>updated 12/1/06 QV</i> <i>updated 5/4/07 QV</i> <i>updated 9/8/07 QV</i> <i>43 45 9/8/07 QV</i> <i>updated 12/11/07 QV</i>						
<b>INTERFERENCE SEARCHED</b>						
Class	Subclass	Date	Examiner			